Power MOSFET

30 V, 7.8 A, Single N–Channel, 2x2 mm WDFN Package

Features

- WDFN Package Provides Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88
- Lowest R_{DS(on)} in 2x2 mm Package
- 1.8 V R_{DS(on)} Rating for Operation at Low Voltage Logic Level Gate Drive
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- This is a Pb–Free Device

Applications

- DC–DC Conversion
- Boost Circuits for LED Backlights
- Optimized for Battery and Load Management Applications in Portable Equipment such as, Cell Phones, PDA's, Media Players, etc.
- Low Side Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±8.0	V
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	I _D	6.0	Α
Current (Note 1)		$T_A = 85^{\circ}C$		4.4	
	t≤5 s	T _A = 25°C		7.8	
Power Dissipation (Note 1)	Steady State T _A = 25°C		PD	1.92	W
	t ≤ 5 s			3.3	
Continuous Drain		T _A = 25°C	I _D	3.6	Α
Current (Note 2)	Steady	T _A = 85°C		2.6	
Power Dissipation (Note 2)	State	T _A = 25°C	PD	0.70	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	28	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C
Source Current (Body Diode) (Note 2)			۱ _S	3.0	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

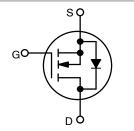
2. Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm2, 2 oz Cu.



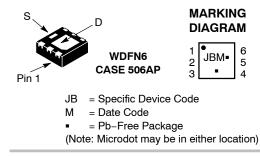
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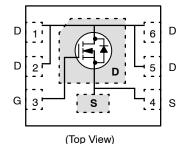
V _{(BR)DSS}	R _{DS(on)} MAX	ID MAX (Note 1)
	35 mΩ @ 4.5 V	
30 V	45 mΩ @ 2.5 V	7.8 A
	55 mΩ @ 1.8 V	



N-CHANNEL MOSFET



PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJS4159NT1G	WDFN6 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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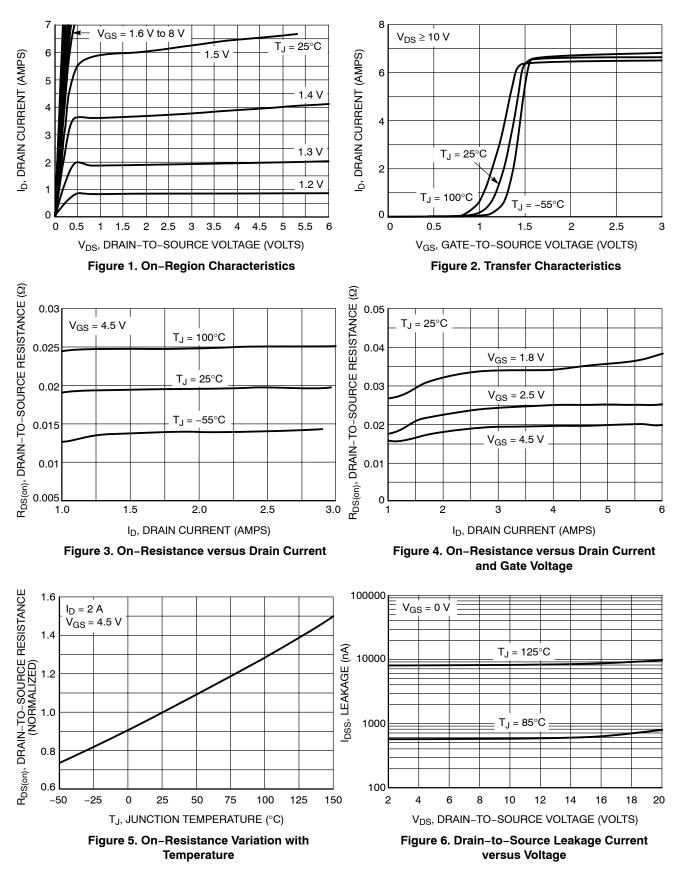
THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	65	
Junction-to-Ambient – t \leq 5 s (Note 3)	$R_{ hetaJA}$	38	°C/W
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{\theta JA}$	180	

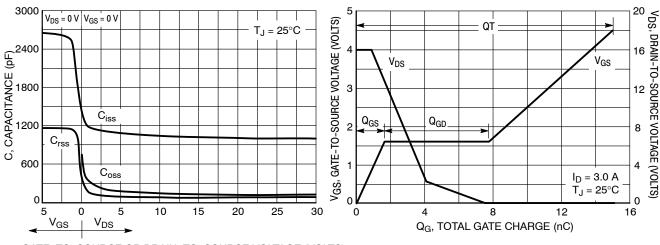
Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

MOSEET ELECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

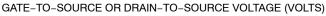
Parameter	Symbol	Test Condition	ns	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = 25$	0 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = 250 \ \mu$ A, Ref to 25°C			20		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			1.0	μΑ
		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	T _J = 65°C			1.0	
			T _J = 85°C			5.0	1
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±	8.0 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 25	50 μA	0.4	0.7	1.0	V
Negative Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.18		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = 4.5, I_D = 2.0 \text{ A}$			20.3	35	mΩ
		V _{GS} = 2.5, I _D = 2	V _{GS} = 2.5, I _D = 2.0 A		25.8	45	-
		V _{GS} = 1.8, I _D = 1.8 A			35.2	55	
Forward Transconductance	9 _{FS}	V _{DS} = 16 V, I _D = 2.0 A			5.3		S
CHARGES, CAPACITANCES AND GA	TE RESISTANC	CE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V			1045		pF
Output Capacitance	C _{OSS}				115.5		
Reverse Transfer Capacitance	C _{RSS}				45.3		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 2.0 \text{ A}$			12.1	13	nC
Threshold Gate Charge	Q _{G(TH)}				1.2		
Gate-to-Source Charge	Q _{GS}				1.9		
Gate-to-Drain Charge	Q _{GD}				2.7		1
Gate Resistance	R _G				3.65		Ω
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(ON)}				6.8		ns
Rise Time	t _r	V_{GS} = 4.5 V, V_{DD} = 15 V, I_{D} = 2.0 A, R_{G} = 3.0 Ω			12.4		1
Turn-Off Delay Time	t _{d(OFF)}				26		1
Fall Time	t _f				5.1		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						-
Forward Recovery Voltage	V _{SD}	V_{GS} = 0 V, IS = 2.0 A	T _J = 25°C		0.71	1.2	
			T _J = 125°C		0.58		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, d _{ISD} /d _t = 100 A/μs, I _S = 1.0 A			15	35	
Charge Time	ta				9.0		ns
Discharge Time	t _b				6.0		1
Reverse Recovery Time	Q _{RR}				7.0		nC



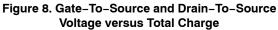
TYPICAL PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)

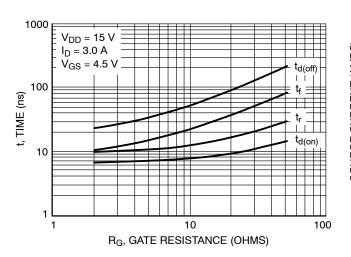


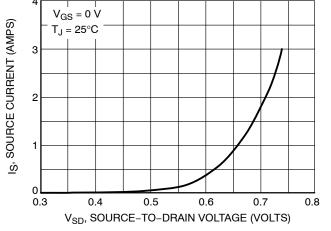
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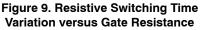


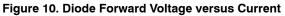


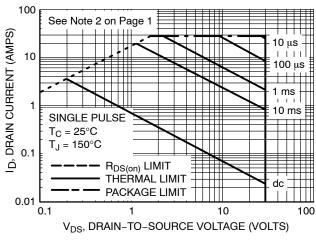




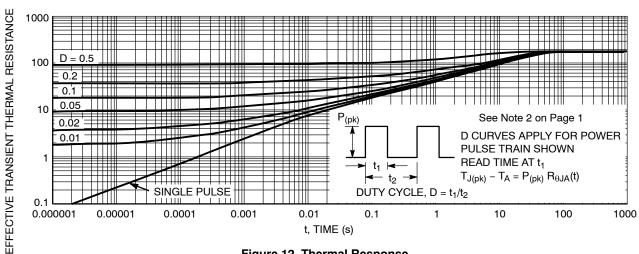












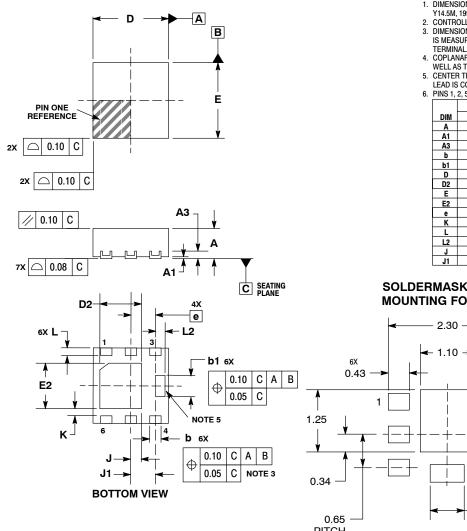
TYPICAL PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)



PACKAGE DIMENSIONS

WDFN6 2x2 CASE 506AP

ISSUE B

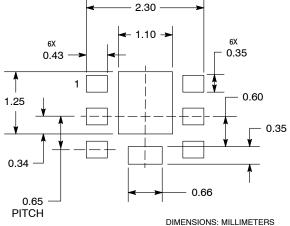


NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20mm FROM
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- CENTER TERMINAL LEAD IS OPTIONAL TERMINAL LEAD IS CONNECTED TO TERMINAL LEAD # 4. PINS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

PINS 1, 2, 5 AND 6 ARE TIED				
	MILLIMETERS			
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
A3	0.20 REF			
b	0.25	0.35		
b1	0.51	0.61		
D	2.00 BSC			
D2	1.00	1.20		
E	2.00 BSC			
E2	1.10	1.30		
е	0.65 BSC			
K	0.15 REF			
L	0.20	0.30		
L2	0.20	0.30		
J	0.27 REF			
J1	0.65 REF			

SOLDERMASK DEFINED **MOUNTING FOOTPRINT***



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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